

## N-Channel Enhancement Mode MOSFET

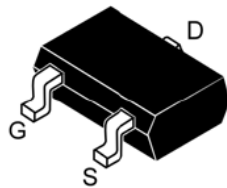
- Features**

20V/3A ,  
 $R_{DS(ON)}=30m\Omega(\text{typ.}) @ V_{GS}=10V$   
 $R_{DS(ON)}=35m\Omega(\text{typ.}) @ V_{GS}=4.5V$   
 $R_{DS(ON)}=45m\Omega(\text{typ.}) @ V_{GS}=2.5V$   
 Super High Dense Cell Design  
 Reliable and Rugged  
 Lead Free Available (RoHS Compliant)

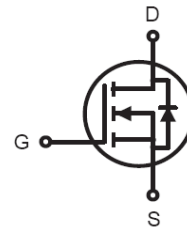
- General Description**

Power Management in Notebook Computer ,  
 Portable Equipment and Battery Powered Systems.

- Pin Configuration**



SOT23



- Absolute Maximum Ratings @  $T_A = 25^\circ\text{C}$  unless otherwise specified**

Symbol	Parameter	Rating	Unit	
$V_{DSS}$	Drain-Source Voltage	20	V	
$V_{GSS}$	Gate-Source Voltage	$\pm 8$		
$I_D$	Continuous Drain Current	3	A	
$I_{DM}$	300 $\mu\text{s}$ Pulsed Drain Current			
$I_S$	Diode Continuous Forward Current	1	A	
$T_J$	Maximum Junction Temperature	150	$^\circ\text{C}$	
$T_{STG}$	Storage Temperature Range	-55 to 150		
$P_D$	Maximum Power Dissipation	$T_A=25^\circ\text{C}$	0.83	W
		$T_A=100^\circ\text{C}$	0.3	
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	150	$^\circ\text{C/W}$	

**Notes:**

mounted on a 1in<sup>2</sup> FR-4 board with 2oz. Copper in a still air environment at 25 $^\circ\text{C}$ , the current rating is based on the DC (<10s) test conditions , for each single die. Pulse Test: Pulse Width < 300  $\mu\text{S}$ , Duty Cycle < 2%.

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● **Electrical Characteristics @  $T_A = 25^\circ\text{C}$  unless otherwise specified**

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
$B_{VDSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_{DS}=250\mu A$	20			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=20V, V_{GS}=0V$	25°C		1	$\mu A$
			80°C		30	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu A$	0.5	0.7	1	V
$I_{GSS}$	Gate Leakage Current	$V_{GS}=\pm 12V, V_{DS}=0V$			$\pm 100$	nA
$R_{DS(ON)}$	Drain-Source On-state Resistance	$V_{GS}=10V, I_{DS}=3A$		30		m $\Omega$
		$V_{GS}=4.5V, I_{DS}=3A$		35		
		$V_{GS}=2.5V, I_{DS}=2A$		45		
$V_{SD}$	Diode Forward Voltage	$I_{SD}=1.25A, V_{GS}=0V$		0.7	1.3	V
<b>Gate Charge Characteristics</b>						
$Q_g$	Total Gate Charge	$V_{DS}=10V, V_{GS}=4.5V,$ $I_{DS}=6A$		5	10	nC
$Q_{gs}$	Gate-Source Charge			1		
$Q_{gd}$	Gate-Drain Charge			1.1		
<b>Dynamic Characteristics</b>						
$R_G$	Gate Resistance	$V_{GS}=0V, V_{DS}=0V, F=1MHz$		6		$\Omega$
$C_{iss}$	Input Capacitance	$V_{GS}=0V,$ $V_{DS}=15V,$ Frequency=1.0MHz		420		pF
$C_{oss}$	Output Capacitance			100		
$C_{riss}$	Reverse Transfer Capacitance			60		
$t_{d(ON)}$	Turn-on Delay Time	$V_{DD}=10V, R_L=10\Omega, I_{DS}=1A,$ $V_{GEN}=4.5V, R_G=6\Omega$		8	15	ns
$T_r$	Turn-on Rise Time			6	12	
$t_{d(OFF)}$	Turn-off Delay Time			19	35	
$T_f$	Turn-off Fall Time			7	23	

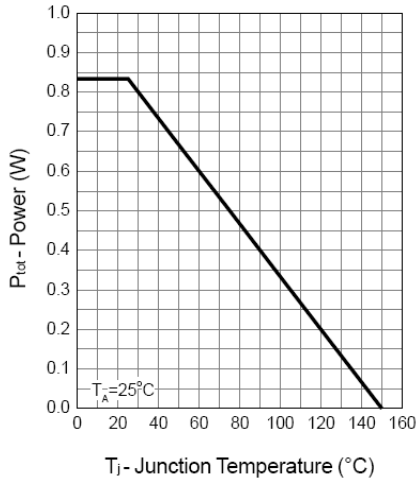
**NOTE:**

1. mounted on a 1in2 FR-4 board with 2oz. Copper in a still air environment at 25°C, the current rating is based on the DC (<10s) test conditions
2. Pulse test ; pulse width $\leq 300\mu s$ , duty cycle $\leq 2\%$ .

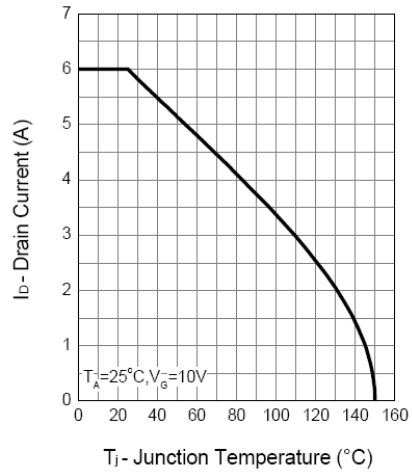
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## ● Typical Performance Characteristics

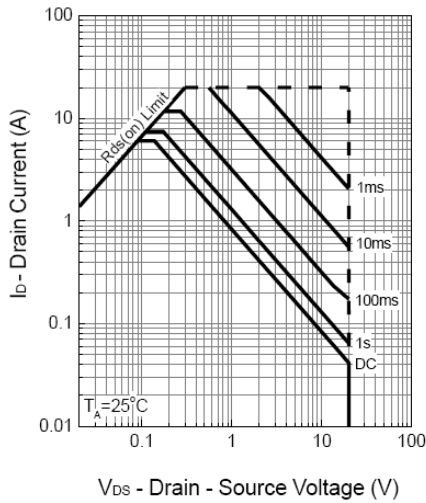
### Power Dissipation



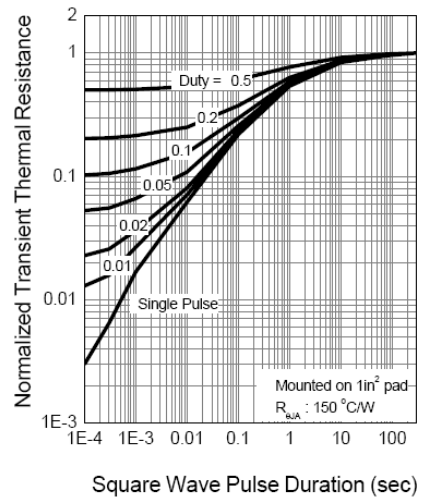
### Drain Current



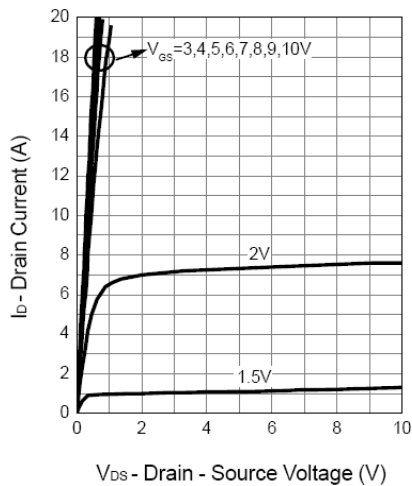
### Safe Operation Area



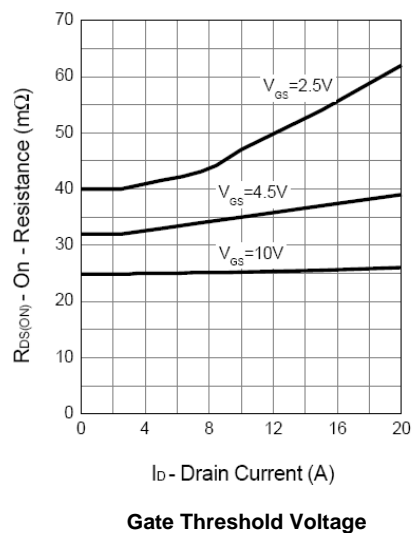
### Thermal Transient Impedance



### Output Characteristics

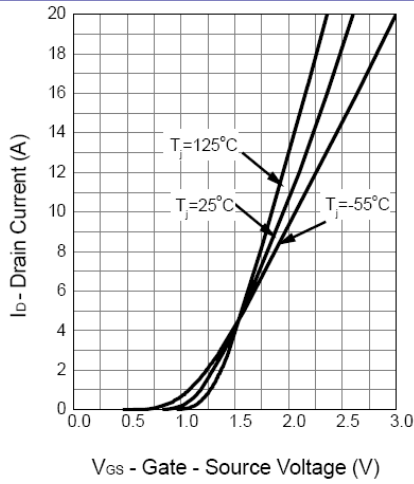


### Drain-Source On Resistance



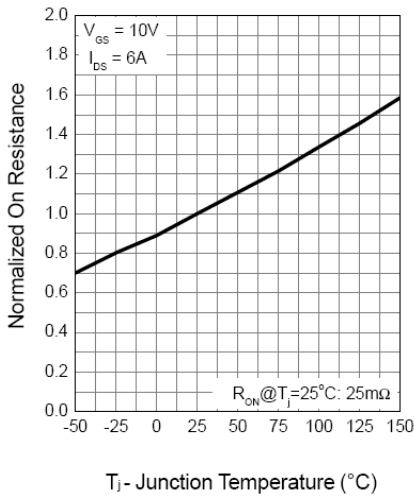
### Transfer Characteristics

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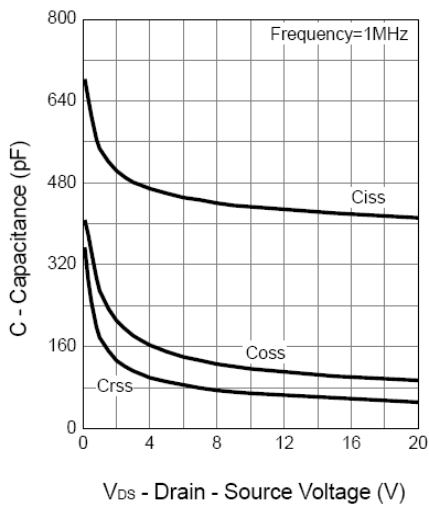
$V_{GS}$  - Gate - Source Voltage (V)

**Drain-Source On Resistance**

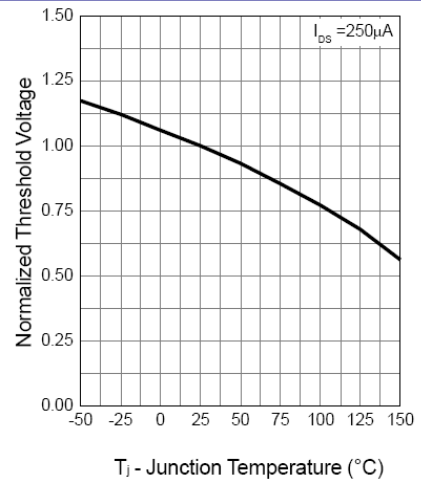


$T_J$  - Junction Temperature ( $^\circ\text{C}$ )

**Capacitance**

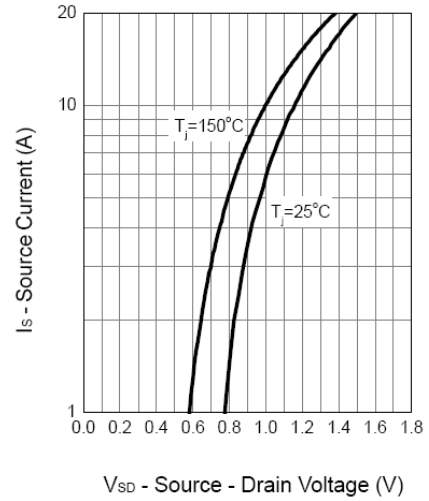


$V_{DS}$  - Drain - Source Voltage (V)



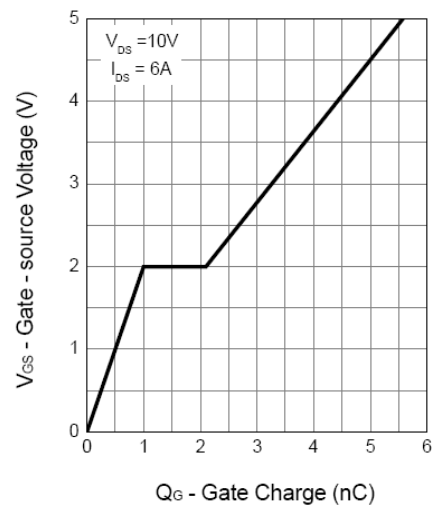
$T_J$  - Junction Temperature ( $^\circ\text{C}$ )

**Source-Drain Diode Forward**



$V_{SD}$  - Source - Drain Voltage (V)

**Gate Charge**



$Q_G$  - Gate Charge (nC)